NAME

CUTEST_cdh - CUTEst tool to evaluate the Hessian of the Lagrangian.

SYNOPSIS

CALL CUTEST_cdh(status, n, m, X, Y, lh1, H_val)

DESCRIPTION

The CUTEST_cdh subroutine evaluates the Hessian matrix of the Lagrangian function $l(x, y) = f(x) + y^T c(x)$ for the problem decoded from a SIF file by the script *sifdecoder* at the point (x, y) = (X,Y). The matrix is stored as a dense matrix.

The problem under consideration is to minimize or maximize an objective function f(x) over all $x \in \mathbb{R}^n$ subject to general equations $c_i(x) = 0$, $(i \in 1, ..., m_E)$, general inequalities $c_i^l(x) \le c_i(x) \le c_i^u(x)$, $(i \in m_E + 1, ..., m)$, and simple bounds $x^l \le x \le x^u$. The objective function is group-partially separable and all constraint functions are partially separable.

ARGUMENTS

The arguments of CUTEST_cdh are as follows

status [out] - integer

the outputr status: 0 for a successful call, 1 for an array allocation/deallocation error, 2 for an array bound error, 3 for an evaluation error,

n [in] - integer

the number of variables for the problem,

m [in] - integer

the total number of general constraints,

X [in] - real/double precision

an array which gives the current estimate of the solution of the problem,

Y [in] - real/double precision

an array which gives the Lagrange multipliers,

lh1 [in] - integer

the actual declared size of the leading dimension of H_val (with lh1 no smaller than n),

H_val [out] - real/double precision

a two-dimensional array which gives the value of the Hessian matrix of the Lagrangian function evaluated at X and Y.

AUTHORS

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SEE ALSO

CUTEst: a Constrained and Unconstrained Testing Environment with safe threads,

N.I.M. Gould, D. Orban and Ph.L. Toint,

Technical Report, Rutherford Appleton Laboratory, 2013.

CUTEr (and SifDec): A Constrained and Unconstrained Testing Environment, revisited,

N.I.M. Gould, D. Orban and Ph.L. Toint,

ACM TOMS, 29:4, pp.373-394, 2003.

CUTE: Constrained and Unconstrained Testing Environment, I. Bongartz, A.R. Conn, N.I.M. Gould and Ph.L. Toint, ACM TOMS, 21:1, pp.123-160, 1995.

sifdecoder(1)